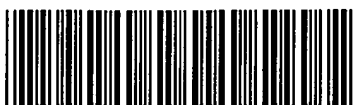


**Search Notes**

Application/Control No.

10/604,605

Examiner

Tuyet Vo

Applicant(s)/Patent under  
Reexamination

LEMAITRE ET AL.

Art Unit

2821

**SEARCHED**

Class	Subclass	Date	Examiner
378	138	6/8/2005	TV
↓	136	↓	↓
	121		
	119		
	129		
↓	140	↓	↓
315	169.4	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
378	138	6/8/2005	TV
↓	136,121	↓	↓
↓	140	↓	↓

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
electrode/cathode/filament, beam/x-ray deflect/reflect/adjust focal/focus spot/location/point,	6/8/2005	TV